Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/688,476	CHIEN, HWEY-CHING	
Examiner	Art Unit	
David Mis	2817	

SEARCHED					
Class	Subclass	Date	Examiner		
331	1A, 8, 17, 25	4/13/2005	DM		
327	12				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
as	above	4/13/2005	DM		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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